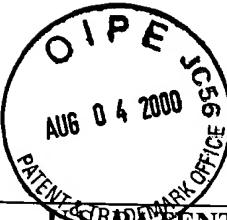


## FORM PTO-1449 (MODIFIED)

LIST OF PUBLICATIONS FOR  
APPLICANT'S INFORMATION  
DISCLOSURE STATEMENT

Applicants: L.D. Bergman et al.  
Docket No.: Y0R9-2000-0205-US1  
Serial No.: 09/614,141  
Filing Date: July 13, 2000  
Group: TBA

## U.S. PATENT DOCUMENTS

## EXAMINER

INITIAL	DOCUMENT NO.	DATE	NAME	CLASS/SUBCLASS	FILING DATE IF APPROPRIATE
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## EXAMINER

INITIAL	DOCUMENT NO.	DATE	COUNTRY	CLASS/SUBCLASS	TRANSLATION YES NO
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## FOREIGN PATENT DOCUMENTS

## EXAMINER

INITIAL	REF NO.	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
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## OTHER DOCUMENTS

## EXAMINER

INITIAL	REF NO.	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
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1. K. Rose, et al., "Entropy-Constrained Tree-Structured Vector Quantizer Design," IEEE Transactions on Image Processing, Vol. 5, No. 2, pp. 393-398, February 1996.
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Examiner

Date Considered

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.